

Notice of References Cited	Application/Control No. 10/656,818	Applicant(s)/Patent Under Reexamination BOTHWELL ET AL.	
	Examiner Alvin C. Chin-Shue	Art Unit 3634	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-225,737	03-1880	De Vaney	5/186.1
	B	US-4,802,553	02-1989	Waters et al.	182/222
	C	US-6,131,700 A	10-2000	Farner, Thomas	182/222
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 348885 A2	01-1990	European Patent	LANGER, RUTH GEB LAYHER	E04G 01/15
	O	EP 347476 A1	12-1989	European Patent	GRUND, GERHARD	E04G 01/15
	P	EP 250612 A1	01-1988	European Patent	BUTTGEREIT, KLAUS	E04G 01/15
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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